

Search Notes

Application/Control No.

10/810,397

Examiner

Danton DeMille

Applicant(s)/Patent under
Reexamination

CHANG, HORNG JIUN

Art Unit

3764

SEARCHED

Class	Subclass	Date	Examiner
601	89,90,92, 93, 94, 95		
	133, 98,		
	100, 101		
	103, 134		
	136	5/28/2006	DDD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR